## Notice of References Cited Application/Control No. 10/734,586 Applicant(s)/Patent Under Reexamination VEECH, RICHARD LEWIS Examiner Nancy L. Zhang Applicant(s)/Patent Under Reexamination VEECH, RICHARD LEWIS Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,136,862	10-2000	Hiraide et al.	514/578
*	В	US-6,380,244	04-2002	Martin et al.	514/449
*	С	US-6,323,237	11-2001	Veech, Richard L.	514/450
*	D	US-2004/0266872	12-2004	Veech, Richard L.	514/557
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-	1 1		
	M	US-			

## FOREIGN' PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name ·	Classification
	N					
	0					
	Р			·		
	Q					
	R					
	s	•				
	Т					

## **NON-PATENT DOCUMENTS**

*	ļ <u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.